

A new approach to build a low-level malicious fault list starting from high-level description and alternative graphs

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Adjusted electrical equivalent circuit model of induction motor with broken rotor bars

Rassõlkin, Anton; Vaimann, Toomas; Belahcen, Anouar; Kallaste, Ants; Petrov, Aleksei; Plokhov, Igor; Kotelnikov, Aleksandr PQ2016 : the 10th International Conference 2016 Electric Power Quality and Supply Reliability Conference (PQ) : August 29-31, 2016, Tallinn, Estonia : proceedings 2016 / p. 213-218 : ill <https://doi.org/10.1109/PQ.2016.7724115>

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